

<b>Search Notes</b>  <b>*1059611</b>  <b>8*</b>	<b>Application/Control No.</b>  10596118	<b>Applicant(s)/Patent Under Reexamination</b>  ISHIO ET AL.
	<b>Examiner</b>  HYUN PARK	<b>Art Unit</b>  2857

SEARCHED			
Class	Subclass	Date	Examiner
702	58,59,117,118,119,120,123,124,125	04/13/2009	HP
714	715, 735	04/13/2009	HP
715	771, 781	04/13/2009	HP

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with the Primary Jeffrey West, TC2800, (class 702)	04/3/2009	HP
Combined text searched	04/13-2009	HP
Consulted TC2800, 101 Panel	04/13/2009	HP
consulted Examiner Kundu, class 702	11/20/2009	HP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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